

**Search Notes**

Application/Control No.

10/733,079

Examiner

Tuyen To

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2825

TT

**SEARCHED**

Class	Subclass	Date	Examiner
716	4	3/24/2006	TT
716	11	3/24/2006	TT
716	7	3/27/2006	TT
716	5	3/27/2006	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	4,5,7,11	3/27/2006	TT
Interference Search. See the attached search printout		3/27/2006	TT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search. Text Search. See the attached Search printout	3/27/2006	TT